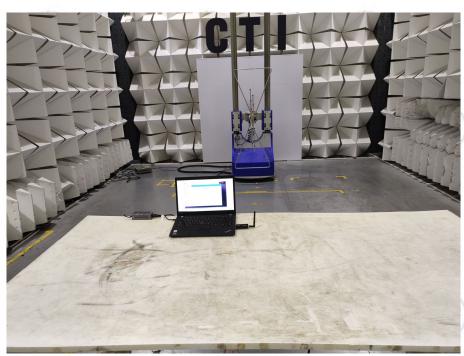


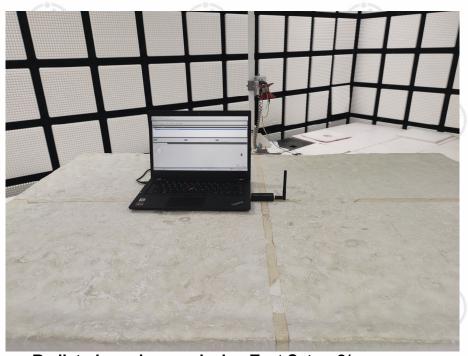
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PHOTOGRAPHS OF TEST SETUP 1

Test mode No.: ZBDongle-P ZBDongle-P(CP2102N-A02-GQFN28R)



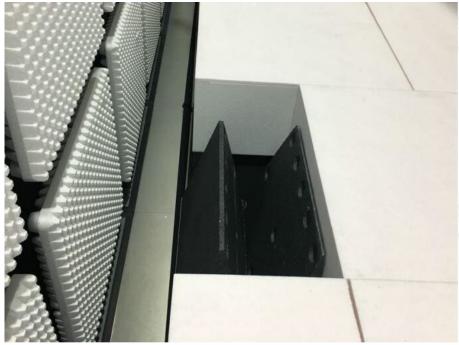
Radiated spurious emission Test Setup-1(Below 1GHz)



Radiated spurious emission Test Setup-2(Above 1GHz)



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Radiated spurious emission Test Setup-3(Above 1GHz) There are absorbing materials under the ground.



Conducted Emissions Test Setup









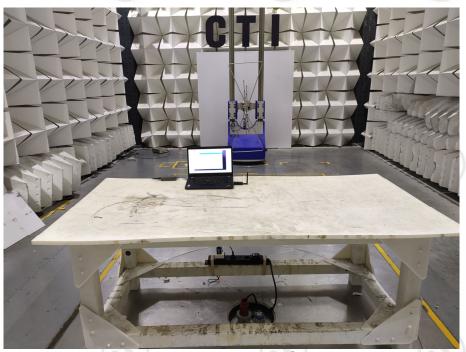






PHOTOGRAPHS OF TEST SETUP 2

Test mode No.: ZBDongle-P ZBDongle-P(CP2102N-A02-GQFN24R)



Radiated spurious emission Test Setup-1(Below 1GHz)



Radiated spurious emission Test Setup-2(Above 1GHz)





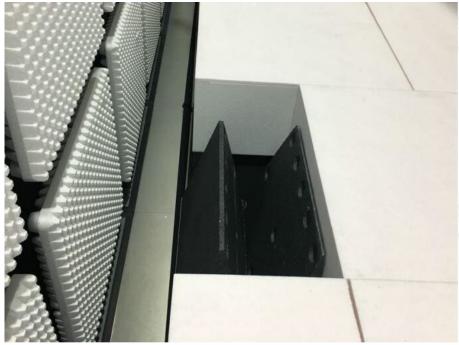








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Radiated spurious emission Test Setup-3(Above 1GHz) There are absorbing materials under the ground.



Conducted Emissions Test Setup









